

Notice of References Cited	Application/Control No. 10/829,439	Applicant(s)/Patent Under Reexamination GOLE ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,061,523	10-1962	FREE ALFRED H	435/14
	B	US-3,092,465	06-1963	ADAMS JR ERNEST C; et. al.	435/14
	C	US-5,620,863	04-1997	Tomasco et al.	435/14
	D	US-5,789,255	08-1998	Yu, Yeung S.	436/95
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Gole et al. PhysChem. Comm. vol. 19, August 30, 2001, pages 1-4. ✓			
	V	Patil et al. Langmuir, vol. 15, September 18, 1999, pages 8197-8206. ✓			
	W	Lala et al. Phys. Chem. Chem. Phys., vol. 2, 2000, pages 2461-2466. ✓			
	X	Sastry et al. Langmuir, vol. 16, February 23, 2000, pages 3553-3556. ✓			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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	H	US-			
	I	US-			
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	K	US-			
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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Damle et al. Langmuir, vol. 17, October 2, 2001, pages 7156-7159.
	V	Mandal et al. Nanotechnology, vol. 12, 2001, pages 358-362.
	W	
	X	

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.